

Optical spectroscopic studies of metal oxides thin films for electrochromic applications

Alice Marciel^{1,2}, Alexandre Bastos², Luiz Pereira¹, Jakka Suresh Kumar¹, Joel Borges³, Filipe Vaz³, Marco Peres⁴, Katharina Lorenz^{4,5}, Rui Silva², Manuel Graça^{1*}

¹ I3N - Physics Department, University of Aveiro, University of Aveiro, 3810-193 Aveiro, Portugal

² CICECO - Aveiro Institute of Materials, Department of Materials and Ceramic Engineering, University of Aveiro, 3810-193 Aveiro, Portugal

³ Physics Center of Minho and Porto Universities (CF-UM-UP), University of Minho, Portugal

⁴ IPFN, Instituto Superior Técnico (IST), Campus Tecnológico e Nuclear, Estrada Nacional 10, P-2695-066 Bobadela LRS, Portugal

⁵ Instituto de Engenharia de Sistemas de Computadores-Microsystems and Nanotechnology (INESC-MN), IST, Lisboa, Portugal

e-mail: alicemarciel@ua.pt

Abstract

The studies of electrochromic materials and devices mainly include viologens, conducting polymers, transition metal oxides (WO_3 , VO_2 , V_2O_5 , MoO_3 , NiO , Cr_2O_5 , Nb_2O_5 , Ta_2O_5), hybrid materials, and metal coordination complexes. Regarding the transition metal oxides, the possible combination of diverse compositions/structures associated with superior electrochromic performance offers exciting prospects for further advancements in electrochromic technology. Recently, there have been significant advances in this field, including the development of new materials, new nanostructures and new composites. These improvements opened opportunities for use in emerging areas and for the development of multifunctional electrochromic devices.

In this study, metal oxides and mixed metal oxides thin films were deposited on different substrates (ITO-coated PET, glass ITO coated and silicon) by reactive magnetron sputtering. A structural threshold as a function of the O_2/Ar flow rate ratio was found, regarding the crystalline to amorphous nature, and the nontransparent appearance with metallic-like conductivity to transparent and dielectric behaviour. All transparent nanometer-thick films present a compact/dense and featureless morphology. The films surface roughness is in the order of a few nanometers and the maximum optical transmission, in the visible range, is 89%. Optical transmittance was also recorded in situ and simultaneously with cyclic voltammetry. Electrochromic behavior of thin films was investigated upon Li^+ intercalation.